Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/190,207	CHEN, JIASHU	
Examiner	Art Unit	
Duc Nauven	2643	

SEARCHED			
Class	Subclass	Date	Examiner
Updated	search	3/2/2006	DN
same	as		
all	previous		
	searches		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Interference search included	3/3/2006	DN